

DIM1200DDM17-PT500

Dual Switch IGBT Module

TRENCH Gen5 TMOS

DS6282-5 May 2021 (LN40943)

Replaces DS6282-4

FEATURES

- Trench Gate IGBT
- 10µs Short Circuit Withstand
- High Thermal Cycling Capability
- Soft Punch Through Silicon
- Isolated AlSiC Base with AlN Substrates
- Lead Free construction
- Low V_{CE(sat)} Device
- High Current Density

APPLICATIONS

- High Reliability Inverters
- Motor Controllers
- Traction Drives
- Active Front End Rectifiers

The Powerline range of high power modules includes half bridge, chopper, dual, single and bi-directional switch configurations covering voltages from 1200V to 6500V and currents up to 2400A.

The DIM1200DDM17-PT500 is a dual switch 1700V, trench gate, insulated gate bipolar transistor (IGBT) module with enhanced field stop and implantation technology. The IGBT has a wide reverse bias safe operating area (RBSOA) plus 10µs short circuit withstand. This device is optimised for traction drives and other applications requiring high thermal cycling capability.

The module incorporates an electrically isolated base plate and low inductance construction enabling circuit designers to optimise circuit layouts and utilise grounded heat sinks for safety.

ORDERING INFORMATION

Order As:

DIM1200DDM17-PT500

Note: When ordering, please use the complete part number

KEY PARAMETERS

V _{CES}		1700V
V _{CE(sat)}	* (typ)	1.8 V
Ic	(max)	1200A
I _{C(PK)}	(max)	2400A

^{*} Measured at the power busbars, not the auxiliary terminals

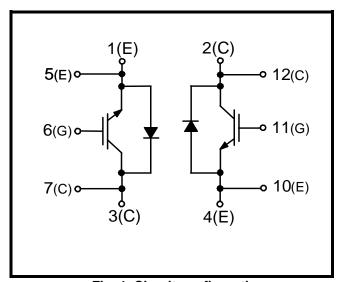


Fig. 1 Circuit configuration



Fig. 2 Package

ABSOLUTE MAXIMUM RATINGS

Stresses above those listed under 'Absolute Maximum Ratings' may cause permanent damage to the device. In extreme conditions, as with all semiconductors, this may include potentially hazardous rupture of the package. Appropriate safety precautions should always be followed. Exposure to Absolute Maximum Ratings may affect device reliability.

T_{case} = 25°C unless stated otherwise

Symbol	Parameter	Test Conditions	Max.	Units
Vces	Collector-emitter voltage	VGE = 0V	1700	V
V _{GES}	Gate-emitter voltage		±20	V
Ic	Continuous collector current	T _{case} = 90°C	1200	Α
I _{C(PK)}	Peak collector current	1ms, T _{case} = 140°C	2400	Α
P _{max}	Max. transistor power dissipation	$T_{case} = 25^{\circ}C, T_{vj} = 150^{\circ}C$	5680	W
l²t	Diode I ² t value	$V_R = 0$, $t_p = 10$ ms, $T_j = 150$ °C	130	kA ² s
Visol	Isolation voltage – per module	Commoned terminals to base plate. AC RMS, 1 min, 50Hz	4000	V
Q_{PD}	Partial discharge – per module	IEC1287, V ₁ = 1800V, V ₂ = 1300V, 50Hz RMS	10	рС

THERMAL AND MECHANICAL RATINGS

Internal insulation material:

Baseplate material:

Creepage distance:

Clearance:

CTI (Comparative Tracking Index):

AIN

AISiC

20mm

10mm

>600

Symbol	Parameter	Test Conditions	Min	Тур.	Max	Units
R _{th(j-c)}	Thermal resistance – transistor (per switch)	Continuous dissipation - junction to case		-	22	°C/kW
R _{th(j-c)}	Thermal resistance – diode (per switch)	Continuous dissipation - junction to case		-	44	°C/kW
R _{th(c-h)}	Thermal resistance – case to heatsink (IGBT)	Mounting torque 5Nm (with mounting grease)		-	12	°C/kW
R _{th(c-h)}	Thermal resistance – case to heatsink (Diode)	Mounting torque 5Nm (with mounting grease)		-	24	°C/kW
	Junction temperature	Transistor	-40	-	150	°C
Tj		Diode	-40	-	150	°C
T _{stg}	Storage temperature range	-	-40	-	150	°C
		Mounting – M6	ı	ı	5	Nm
	Screw torque	Electrical connections – M4		-	2	Nm
		Electrical connections – M8	-	-	10	Nm

ELECTRICAL CHARACTERISTICS

 T_{case} = 25°C unless stated otherwise.

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Ices		V _{GE} = 0V, V _{CE} = V _{CES}			1	mA
	Collector cut-off current	V _{GE} = 0V, V _{CE} = V _{CES} , T _{case} = 125°C			20	mA
		V _{GE} = 0V, V _{CE} = V _{CES} , T _{case} = 150°C			30	mA
I _{GES}	Gate leakage current	V _{GE} = ± 20V, V _{CE} = 0V			0.5	μΑ
V _{GE(TH)}	Gate threshold voltage	Ic = 40mA, V _{GE} = V _{CE}	5.0	6.0	7.0	V
		V _{GE} = 15V, I _C = 1200A		1.8	2.2	V
V _{CE(sat)}	Collector-emitter saturation voltage	V _{GE} = 15V, I _C = 1200A, T _j = 125°C		2.1	2.5	V
	3	V _{GE} = 15V, I _C = 1200A, T _j = 150°C		2.2	2.6	V
l _F	Diode forward current	DC		1200		Α
I _{FM}	Diode maximum forward current	$t_p = 1 ms$		2400		Α
	Diode forward voltage	I _F = 1200A		1.9	2.3	V
V_{F}		I _F = 1200A, T _j = 125°C		2.1	2.5	V
		I _F = 1200A, T _j = 150°C		2.1	2.5	V
Cies	Input capacitance	V _{CE} = 25V, V _{GE} = 0V, f = 100kHz		109		nF
Qg	Gate charge	±15V		11.6		μC
Cres	Reverse transfer capacitance	V _{CE} = 25V, V _{GE} = 0V, f = 100kHz		3.0		nF
L _M	Module inductance – per switch	-		20		nΗ
RINT	Internal transistor resistance – per switch	-		270		μΩ
SC _{Data}	Short circuit current, I _{SC}	$\begin{split} T_{j} &= 150^{\circ}C, \ V_{CC} = 1000V \\ t_{p} &\leq 10 \mu s, \ V_{GE} \leq 15V \\ V_{CE \ (max)} &= V_{CES} - L^{*} \ x \ dI/dt \\ IEC \ 60747-9 \end{split}$		4700		А

Note:

^{*} L is the circuit inductance + L_M

ELECTRICAL CHARACTERISTICS

 $T_{case} = 25$ °C unless stated otherwise

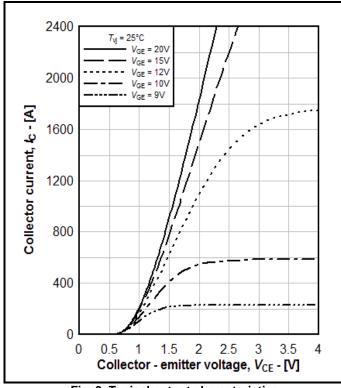
Symbol	Parameter	Test Conditions	Min	Тур.	Max	Units
t _{d(off)}	Turn-off delay time	Ic = 1200A		1200		ns
t _f	Fall time	$V_{GE} = \pm 15V$		400		ns
Eoff	Turn-off energy loss	V _{CE} = 900V		570		mJ
t _{d(on)}	Turn-on delay time	$R_{G(ON)} = 0.5\Omega$		480		ns
t _r	Rise time	$R_{G(OFF)} = 0.5\Omega$		230		ns
Eon	Turn-on energy loss	L _S ~ 150nH		83		mJ
Qrr	Diode reverse recovery charge	I _F = 1200A		240		μC
Irr	Diode reverse recovery current	V _{CE} = 900V		710		Α
Erec	Diode reverse recovery energy	dl _F /dt = 4500A/μs		155		mJ

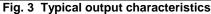
T_{case} = 125°C unless stated otherwise

Symbol	Parameter	Test Conditions	Min	Тур.	Max	Units
t _{d(off)}	Turn-off delay time	Ic = 1200A		1250		ns
t _f	Fall time	$V_{GE} = \pm 15V$		480		ns
Eoff	Turn-off energy loss	V _{CE} = 900V		640		mJ
t _{d(on)}	Turn-on delay time	$R_{G(ON)} = 0.5\Omega$		480		ns
t _r	Rise time	$R_{G(OFF)} = 0.5\Omega$		240		ns
Eon	Turn-on energy loss	Ls ~ 150nH		116		mJ
Qrr	Diode reverse recovery charge	I _F = 1200A		380		μC
Irr	Diode reverse recovery current	V _{CE} = 900V		835		Α
Erec	Diode reverse recovery energy	dl _F /dt = 4500A/μs		265		mJ

T_{case} = 150°C unless stated otherwise

Symbol	Parameter	Test Conditions	Min	Тур.	Max	Units
t _{d(off)}	Turn-off delay time	lc = 1200A		1280		ns
t _f	Fall time	$V_{GE} = \pm 15V$		490		ns
E _{OFF}	Turn-off energy loss	V _{CE} = 900V		660		mJ
t _{d(on)}	Turn-on delay time	$R_{G(ON)} = 0.5\Omega$		480		ns
tr	Rise time	$R_{G(OFF)} = 0.5\Omega$		240		ns
Eon	Turn-on energy loss	Ls ~ 150nH		128		mJ
Qrr	Diode reverse recovery charge	I _F = 1200A		415		μC
Irr	Diode reverse recovery current	V _{CE} = 900V dI _F /dt = 4500A/µs		870		Α
E _{rec}	Diode reverse recovery energy			295		mJ





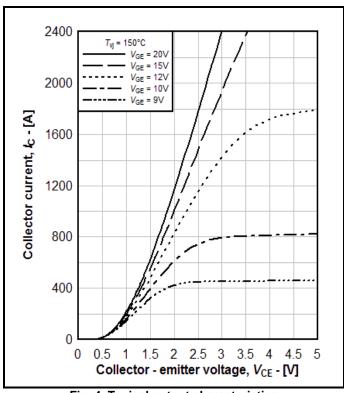


Fig. 4 Typical output characteristics

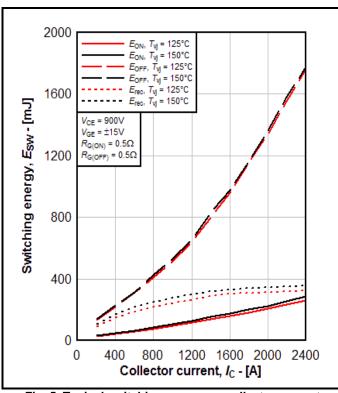


Fig. 5 Typical switching energy vs collector current

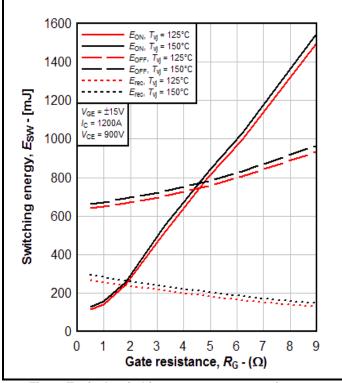


Fig. 6 Typical switching energy vs gate resistance

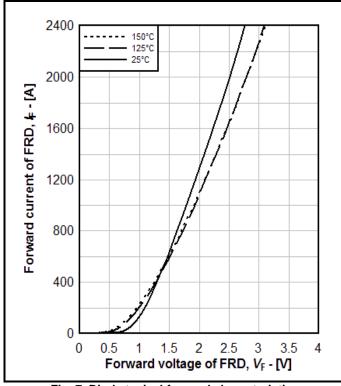


Fig. 7 Diode typical forward characteristics

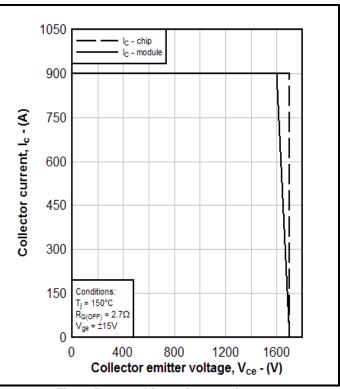


Fig. 8 Reverse bias safe operating area

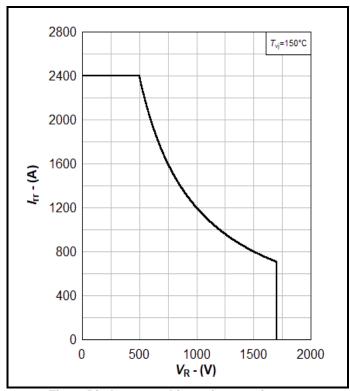


Fig. 9 Diode reverse bias safe operating area

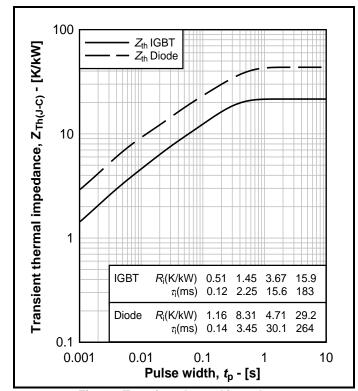


Fig. 10 Transient thermal impedance

PACKAGE DETAILS

For further package information, please visit our website or contact Customer Services. All dimensions in mm, unless stated otherwise.

DO NOT SCALE.

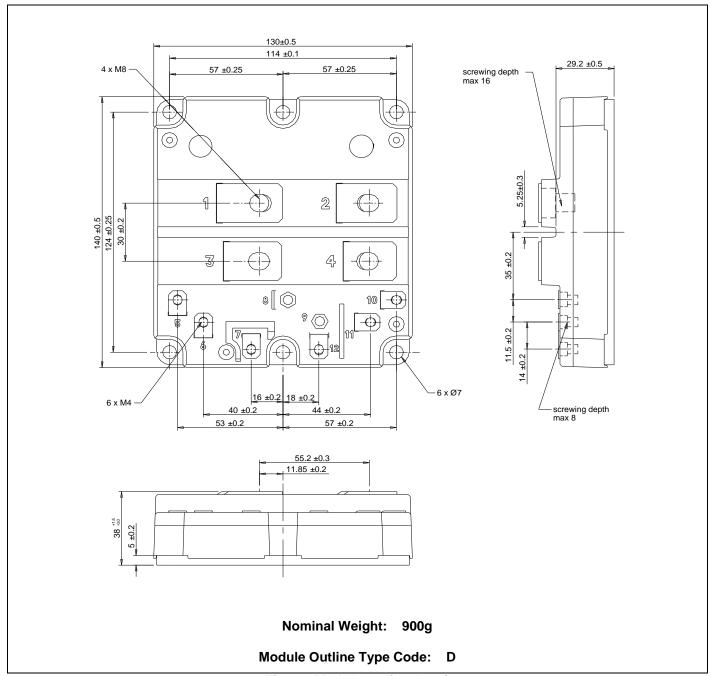


Fig. 11 Module outline drawing

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